Applicant(s)/Patent Under Application/Control No. Reexamination 10/726,117 INOUE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2871 Thoi V Duong **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY US-6,567,144 B1 05-2003 Kim et al. 349/128 Α В US-С US-D US-US-E US-F US-G US-Н ı US-US-J US-US-US-М FOREIGN PATENT DOCUMENTS Date **Document Number** Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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